

**Amendments to the Claims:**

This listing of claims will replace all prior versions and listings of claims in this application.

**Listing of Claims:**

1. (Currently Amended) A device, comprising:  
a layer of a first conductivity type;  
a first transistor disposed in the layer;  
a body contact region disposed in the layer; and  
a resistance region disposed in the layer between the first transistor and the body contact region to substantially electrically isolate the first transistor from the body contact region, the resistance region having a resistivity higher than a resistivity of the layer.
2. (Original) The device of claim 1, further comprising:  
a second transistor disposed in the layer, wherein the second transistor is disposed on a same side of the resistance region as the body contact region.
3. (Original) The device of claim 1, wherein the body contact region is adapted to be coupled to ground and the first conductivity type is p-type.
4. (Original) The device of claim 1, wherein the body contact region is adapted to be coupled to a power supply voltage and the first conductivity type is n-type.
5. (Original) The device of claim 1, further comprising a substrate, the layer being disposed on top of the substrate.

6. (Original) The device of claim 1, wherein the resistance region has an impurity concentration lower than an impurity concentration of the layer.
7. (Original) The device of claim 1, further comprising a discrete capacitor coupled between a body and a source of the first transistor.
8. (Original) The device of claim 1, wherein the resistance region occupies substantially an entire cross-sectional area of the layer between the first transistor and the body contact region.
9. (Original) The device of claim 1, further comprising:  
a second transistor coupled in series with the first transistor and having a control electrode adapted to receive an input signal of the device, the first transistor having a control electrode adapted to receive a bias voltage, and the body contact region being adapted to be coupled to a first one of a power supply voltage and ground; and  
a load having a first end coupled to the first transistor and a second end adapted to be coupled to a second one of the power supply voltage and ground, a body of the second transistor being adapted to be coupled to the first one of the power supply voltage and ground.
10. (Original) The device of claim 9, wherein the first and second transistors are n-type conductivity transistors.
11. (Original) The device of claim 9, wherein the resistance region is adapted to substantially isolate a body of the first transistor from ground.
12. (Original) The device of claim 9, wherein the resistance region is adapted to substantially isolate a body of the first transistor from ground when the input signal is at or above a predetermined operating frequency.

13. (Original) The device of claim 9, wherein the load is an inductance.

14. (Original) The device of claim 1, wherein the layer is an epitaxial layer.

15.-24. (Cancelled)

25. (Previously Presented) A device, comprising:

a layer of a first conductivity type formed directly on a semiconductor substrate;

a first transistor disposed in the layer;

a body contact region disposed in the layer; and

a resistance region disposed in the layer between the first transistor and the body contact region, the resistance region having a resistivity higher than a resistivity of the layer.

26. (Previously Presented) The device of claim 25, wherein the semiconductor substrate is of said first conductivity type.

27. (Previously Presented) The device of claim 25, wherein the resistance region substantially isolates the first transistor from the body contact region.

28. (Previously Presented) The device of claim 25, further comprising:

a second transistor disposed in the layer, wherein the second transistor is disposed on a same side of the resistance region as the body contact region.

29. (Previously Presented) The device of claim 25, wherein the body contact region is adapted to be coupled to ground.

30. (Previously Presented) The device of claim 25, wherein the layer is an epitaxial layer.

31. (Previously Presented) The device of claim 25, wherein the resistance region has an impurity concentration lower than an impurity concentration of the layer.

32. (Previously Presented) The device of claim 25, further comprising a discrete capacitor coupled between a body and a source of the first transistor.

33. (Previously Presented) The device of claim 25, wherein the resistance region occupies substantially an entire cross-sectional area of the layer between the first transistor and the body contact region.

34. (New) A device, comprising:  
an epitaxial layer of a first conductivity type;  
a first transistor disposed in the layer;  
a body contact region disposed in the layer; and  
a resistance region disposed in the layer between the first transistor and the body contact region, the resistance region having a resistivity higher than a resistivity of the layer.

35. (New) The device of claim 34, further comprising:  
a second transistor disposed in the epitaxial layer, wherein the second transistor is disposed on a same side of the resistance region as the body contact region.

36. (New) The device of claim 34, further comprising a substrate, the epitaxial layer being disposed on top of the substrate.

37. (New) A device, comprising:  
a layer of a first conductivity type;

a first transistor disposed in the layer;  
a body contact region disposed in the layer; and  
a resistance region disposed in the layer between the first transistor and the body contact region,  
the resistance region having a resistivity higher than a resistivity of the layer, wherein the  
resistance region has an impurity concentration lower than an impurity concentration of the layer.

38. (New) The device of claim 37, further comprising:

a second transistor disposed in the layer, wherein the second transistor is disposed on a  
same side of the resistance region as the body contact region.

39. (New) The device of claim 37, further comprising a substrate, the layer being  
disposed on top of the substrate.